

<b>Notice of References Cited</b>	Application/Control No. 10/058,382	Applicant(s)/Patent Under Reexamination HIGUCHI ET AL.	
	Examiner Thien D. Tran	Art Unit 2616	Page 1 of 1

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*	C	US-6,868,076 B2	03-2005	Schilling et al.	370/335
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	M	US-			

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**NON-PATENT DOCUMENTS**

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